

Notice of References Cited	Application/Control No. 10/600,545	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner David Mis	Art Unit 2817	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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	U	Abstract for KR 2003083887 A, Lee et al, 11/01/2003.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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